Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office		Application No. w/154, 5/2 New Divisional Applin.		
	by Applicant (Use several sheets if necessary) Fig. 1		Applicant Hajime Kimura		
(Use several she			Group Art Unit Unknown 2876		

U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
D.D.	AA	2001/0055841	12/27/01	Yamazaki, et al.			
D.D.	AB	5,530,269	06/25/96	Tang			
D.D.	AC	5,550,066	08/27/96	Tang, et al.			
D.D.	AD	5,684,365	11/04/97	Tang, et al.			
D.D.	ΑE	5,734,452	03/31/98	Yamaue, et al.		\ /	
D.D.	AF	5,929,474	07/27/99	Huang, et al.		\	
D.D.	AG	6,091,078	07/18/00	Codama		γ	
D.D.	AH	6,120,338	09/19/00	Hirano, et al.		Λ	
D.D.	ΑI	6,215,244	04/10/01	Kuribayashi, et al.		/\	
D.D.	AJ	6,246,179	06/12/01	Yamada		/	
D.D.	AK	6,366,025	04/02/02	Yamada	1		
D.D.	AL	6,429,584	08/06/02	Kubota			
D.D.	AM	6,433,487	08/13/02	Yamazaki			
D.D.	AN	6,515,310	02/04/03	Yamazaki			
プ. ダ.	AO	6,515,428	02/04/03	Yeh, et al.	1		
D.D.	AP	6,522,066	02/18/03	Sheu, et al.	1		
D.D.	AQ	6,522,079	02/18/03	Yamada			
D.D.	AR	6,597,121	07/22/03	Imura	7		

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner	Desig.	Document	Publication	Country or			Trans	lation
Initial	ID	Number	Date	Patent Office	Class	Subclass	Yes	No
D.D.	AS	2000-040584	2/8/2000	JAPAN		>~	XX	

Other Documents (include Author, Title, Date, and Place of Publication)						
Examiner Initial	Desig. ID	Document				
	AT					

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